



20V N-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

V _{(BR)DSS}	R _{DS(ON)} max	I _D max T _A = 25°C
	0.99Ω @ $V_{GS} = 4.5V$	760mA
20V	1.2Ω @ V _{GS} = 2.5V	700mA
	2.4Ω @ V _{GS} = 1.8V	500mA
	3.0Ω @ V _{GS} = 1.5V	350mA

Description and Applications

This MOSFET has been designed to minimize the on-state resistance $(R_{DS(on)})$ and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

- General Purpose Interfacing Switch
- Power Management Functions
- Analog Switch

Features and Benefits

- Low On-Resistance
- Very low Gate Threshold Voltage, 1.0V max
- Low Input Capacitance
- Fast Switching Speed
- Ultra-Small Surface Mount Package 1mm x 0.6mm
- Low Package Profile, 0.5mm Maximum Package height
- ESD Protected Gate
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 standards for High Reliability

Mechanical Data

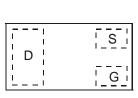
- Case: X1-DFN1006-3
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections Indicator: See diagram
- Terminals: Finish NiPdAu over Copper leadframe. Solderable per MIL-STD-202, Method 208 (24)
- Weight: 0.001 grams (approximate)



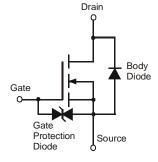




Bottom View



Top View Package Pin Configuration



Equivalent Circuit

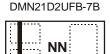
Ordering Information (Note 4)

Part Number	Marking	Reel size (inches)	Tape width (mm)	Quantity per reel
DMN21D2UFB-7B	NN	7	8	10,000

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com.

Marking Information



NN = Product Type Marking Code

Top View Bar Denotes Gate and Source Side



Maximum Ratings @T_A = 25°C unless otherwise specified

Characteristic			Symbol	Value	Units
Drain-Source Voltage			V_{DSS}	20	V
Gate-Source Voltage			V_{GSS}	±12	V
Continuous Drain Current (Note 6) 1/ 4 51/	Steady State	$T_A = 25$ °C $T_A = 70$ °C	I _D	760 610	mA
Continuous Drain Current (Note 6) V _{GS} = 4.5V	t<5s	$T_A = 25^{\circ}C$ $T_A = 70^{\circ}C$	I _D	850 700	mA
Maximum Continuous Body Diode Forward Current (Note 6)			I _S	0.8	Α
Pulsed Drain Current (Note 7)			I _{DM}	1.0	А

Thermal Characteristics @T_A = 25°C unless otherwise specified

Characteristic	Symbol	Value	Units		
Total Power Dissipation (Note 4)	$T_A = 25$ °C	P_{D}	0.38	W	
Total Power Dissipation (Note 4)	T _A = 70°C	PD	0.25		
Thermal Resistance, Junction to Ambient (Note 4)	Steady State	2	325	°C/W	
Thermal Resistance, Junction to Ambient (Note 4)	t<5s	$R_{\theta JA}$	244	C/VV	
Total Power Dissipation (Note 5)	$T_A = 25$ °C	D	0.9	W	
Total Power Dissipation (Note 5)	T _A = 70°C	P_{D}	0.57		
Thermal Begintenes, Junction to Ambient (Note 5)	Steady State	_	141	°C/W	
Thermal Resistance, Junction to Ambient (Note 5)	t<5s	$R_{\theta JA}$	106	C/VV	
Operating and Storage Temperature Range		$T_{J,}T_{STG}$	-55 to 150	°C	

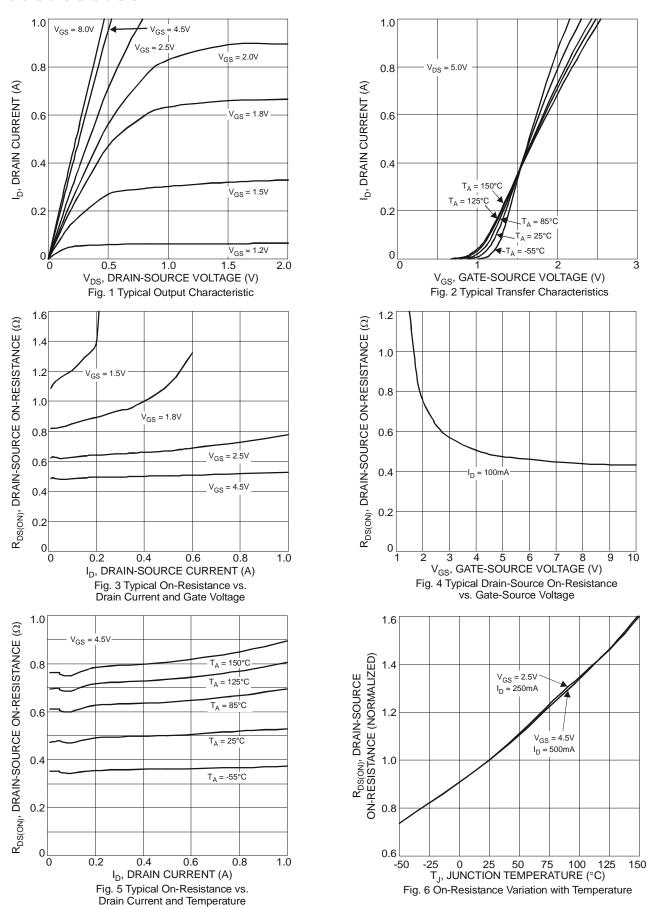
Electrical Characteristics @T_A = 25°C unless otherwise specified

Characteristic		Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 8)							
Drain-Source Breakdown Voltage		20	-	-	V	$V_{GS} = 0V, I_D = 250\mu A$	
Zero Gate Voltage Drain Current @T _c = 25°C	C I _{DSS}	-	-	100	nA	$V_{DS} = 20V, V_{GS} = 0V$	
Gate-Source Leakage	I _{GSS}	-	-	±1	μA	$V_{GS} = \pm 10V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 8)							
Gate Threshold Voltage	V _{GS(th)}	0.4	-	1.0	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	
		-	0.6	0.99		$V_{GS} = 4.5V, I_D = 100mA$	
Static Drain-Source On-Resistance	D	-	0.7	1.2	Ω	$V_{GS} = 2.5V, I_D = 50mA$	
Static Drain-Source On-Resistance	R _{DS} (ON)	-	0.9	2.4	2.2	$V_{GS} = 1.8V, I_D = 20mA$	
		-	1.2	3.0		$V_{GS} = 1.5V, I_D = 10mA$	
Forward Transfer Admittance	Y _{fs}	180	-	-	mS	$V_{DS} = 10V, I_D = 400mA$	
Diode Forward Voltage	V_{SD}	-	0.6	1.0	V	$V_{GS} = 0V, I_{S} = 150mA$	
DYNAMIC CHARACTERISTICS (Note 9)							
Input Capacitance	C _{iss}	-	27.6	-	pF	101/11/	
Output Capacitance		-	4.0	-	pF	$V_{DS} = 16V, V_{GS} = 0V,$ - f = 1.0MHz	
Reverse Transfer Capacitance	C _{rss}	-	2.8	-	pF	T = T.OIVII IZ	
Total Gate Charge V _{GS} = 4.5V	Q_{g}	-	0.41	-	nC		
Total Gate Charge V _{GS} = 10V	Q_g	-	0.93	-	nC	\\\ 40\\\ I 250~^4	
Gate-Source Charge	Q _{gs}	-	0.06	-	nC	$V_{DS} = 10V, I_D = 250mA$	
Gate-Drain Charge	Q_{gd}	-	0.06	-	nC		
Turn-On Delay Time	t _{D(on)}	-	3.5	-	ns	10)/)/ 15)/	
Turn-On Rise Time	t _r	-	4.2	-	ns	$V_{DD} = 10V, V_{GS} = 4.5V,$	
Turn-Off Delay Time	t _{D(off)}	-	19.6	-	ns	$R_L = 47\Omega, R_G = 10\Omega,$ $I_D = 200\text{mA}$	
Turn-Off Fall Time	t _f	-	9.8	-	ns	1D = 20011IA	

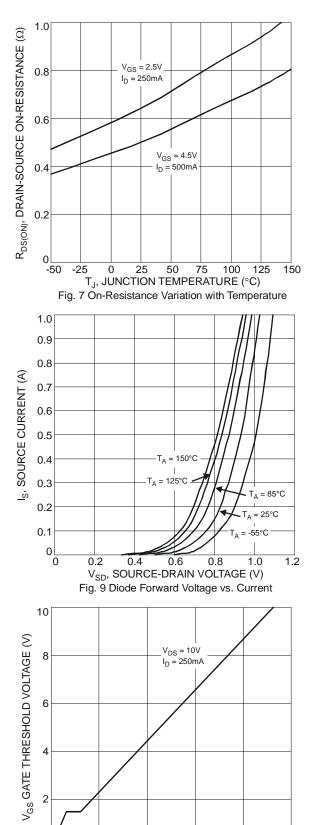
Notes:

- 5. Device mounted on FR-4 PCB, with minimum recommended pad layout.6. Device mounted on FR-4 substrate PC board, 2oz copper, with thermal vias to bottom layer 1inch square copper plate
- 7. Device mounted on minimum recommended pad layout test board, 10µs pulse duty cycle = 1%.
- 8. Short duration pulse test used to minimize self-heating effect.
- 9. Guaranteed by design. Not subject to product testing.









0.6

8.0

1.0

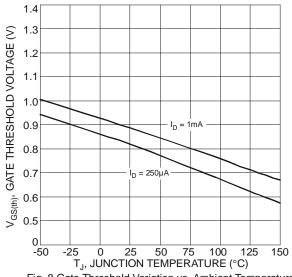
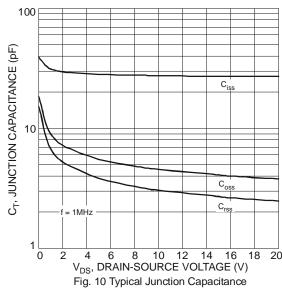
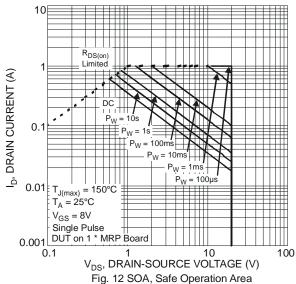


Fig. 8 Gate Threshold Variation vs. Ambient Temperature





0.2

0.4

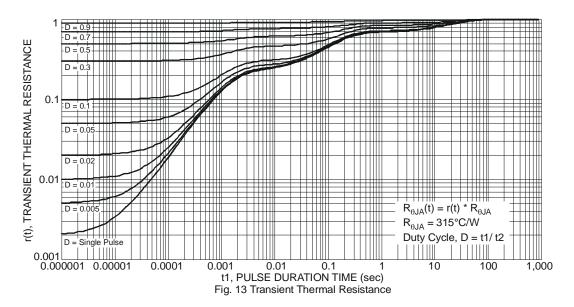
 Q_g , TOTAL GATE CHARGE (nC)

Fig. 11 Gate Charge

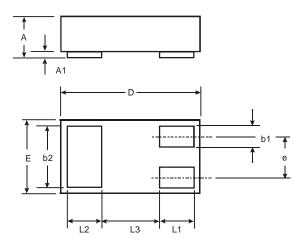
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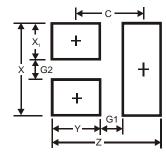


Package Outline Dimensions



X1-DFN1006-3					
Dim	Min	Max	Тур		
Α	0.47	0.53	0.50		
A1	0	0.05	0.03		
b1	0.10	0.20	0.15		
b2	0.45	0.55	0.50		
D	0.95	1.075	1.00		
Е	0.55	0.675	0.60		
е	—	_	0.35		
L1	0.20	0.30	0.25		
L2	0.20	0.30	0.25		
L3	_	_	0.40		
All	All Dimensions in mm				

Suggested Pad Layout



Dimensions	Value (in mm)
Z	1.1
G1	0.3
G2	0.2
Х	0.7
X1	0.25
Y	0.4
С	0.7



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